

<b>Notice of References Cited</b>	Application/Control No. 10/606,885		Applicant(s)/Patent Under Reexamination LICHTENBERGER ET AL.	
	Examiner Martin J Angebrannt		Art Unit 1756	Page 1 of 2

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,171,643	12-1992	Suzuki et al.	428/671
	B	US-6,841,049	01-2005	Ito et al.	204/298.15
	C	US-2002/0034603	03-2002	Nee, Han H.	428/64.1
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	K	US-			
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	1122723	08-2001	EP	Aratani et al.	***
	O	07-207384	08-1995	Japan	Murakishi et al.	***
	P	1073292	06-1993	China	Li et al.	***
	Q	48-095311	12-1973	Japan	***	***
	R	07-228931	08-1995	Japan	Tanka	***
	S	0064777	11-1982	EP	Dirks et al.	**
	T	07-301705	11-1995	Japan	Takagi et al.	**

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	STN abstract of Li et al., "Internal oxidation and properties of palladium-40% silver-1% Re(Re = Sm, Eu, Gd) alloys", Guijinshu Vol. 11(2) pp. 18-22 (1990)			
	V	STN abstract of Xie et al., CN 1301875 teaches a CuAgFe alloys with 0.5% Sm.			
	W	by STN abstract of Ivanov, et al., "Heats of formation for silver-barium and silver-samarium melts", Khimicheskije I Boilogicheskije Nauki, Vol. 8, pp 43-44 (1990).			
	X	Fert et al., "Skew scattering by a rare-earth impurities in silver gold and aluminum", Physical Review B Vol. 13(1) pp. 397-411.			

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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	V	
	W	
	X	

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